Full

TEST REPORT

No. I18D00223-SRD01

For

Client : Shanghai Sunmi Technology Co.,Ltd.

Production : Self-Checkout Kiosk

Model Name : F4600

Brand Name : SUNMI

FCC ID : 2AH25F4600

Hardware Version: V2.1

Software Version: 1.0.13

Issued date: 2019-01-15

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of ECIT Shanghai.

Test Laboratory:

ECIT Shanghai, East China Institute of Telecommunications

Add: 7-8F, G Area, No.668, Beijing East Road, Huangpu District, Shanghai, P. R. China

Tel: (+86)-021-63843300, E-Mail: welcome@ecit.org.cn

Revision Version

Report Number	Revision	Date	Memo
I18D00223-SRD01	00	2019-01-02	Initial creation of test report
I18D00223-SRD01	01	2019-01-10	Second creation of test report
I18D00223-SRD01	02	2019-01-15	Third creation of test report

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1. Test Laboratory

1.1. Testing Location

Company Name:	ECIT Shanghai, East China Institute of Telecommunications
Address:	7-8F, G Area, No. 668, Beijing East Road, Huangpu District, Shanghai, P. R. China
Postal Code:	200001
Telephone:	(+86)-021-63843300
Fax:	(+86)-021-63843301
FCC registration No	958356

1.2. Testing Environment

Normal Temperature:	15-35℃
Extreme Temperature:	0/+40℃
Relative Humidity:	25-75%

1.3. Project data

Project Leader:	Chen Minfei
Testing Start Date:	2018-12-17
Testing End Date:	2019-01-10

1.4. Signature

Yang Dejun
(Prepared this test report)

Shi Hongqi
(Reviewed this test report)

Zheng Zhongbin
(Approved this test report)

2. Client Information

2.1. Applicant Information

Company Name:	Shanghai Sunmi Technology Co.,Ltd.
Address:	Room 605,Block 7,KIC Plaza,No.388 Song Hu Road Yang Pu District
Telephone:	18721763396
Postcode:	200433

2.2. Manufacturer Information

Company Name:	Shanghai Sunmi Technology Co.,Ltd.
Address:	Room 605,Block 7,KIC Plaza,No.388 Song Hu Road Yang Pu District
Telephone:	18721763396
Postcode:	200433

3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

EUT Description	Self-Checkout Kiosk
Model name	F4600
BT Frequency	2402MHz-2480MHz
BT Channel	Channel0-Channel78
BT type of modulation	GFSK/ π /4 DQPSK/8DPSK
GSM Frequency Band	/
UMTS Frequency Band	/
CDMA Frequency Band	/
LTE Frequency Band	/
Additional Communication Function	BT4.0,BLE; WiFi 802.11b,g,n.
Extreme Temperature	0/+40℃
Nominal Voltage	12V
Extreme High Voltage	220V
Extreme Low Voltage	5V

Note: Photographs of EUT are shown in ANNEX A of this test report.

3.2. Internal Identification of EUT used during the test

EUT ID*	Model Name	SN or IMEI	HW Version	SW Version	Date of receipt
N01	F4600	/	V2.1	1.0.13	2018-11-20
N02	F4600	/	V2.1	1.0.13	2018-11-20

*EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE used during the test

AE ID*	Description	SN
AE1	RF cable	---
AE2	---	---

*AE ID: is used to identify the test sample in the lab internally.

4. Reference Documents

4.1. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC Part15	FCC CFR 47, Part 15,Subpart C: 15.205 Restricted bands of operation; 15.209 Radiated emission limits, general requirements; 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz, and 5725-5850MHz.	2018/10/1
ANSI C63.10	American National Standard of Procedures for Compliance Testing of Unlicensed Wireless Devices	2013

5. Summary of Test Results

A brief summary of the tests carried out is shown as following.

Measurement Items	Sub-clause of Part15C	Sub-clause of IC	Verdict
Maximum Peak Output Power	15.247(b)	/	P
20dB Occupied Bandwidth	15.247(a)	/	P
Band Edges Compliance	15.247(b)	/	P
Time Of Occupancy (Dwell Time)	15.247(a)	/	P
Carrier Frequency Separation	15.247(a)	/	P
Number Of Hopping Channels	15.247(a)	/	P
Transmitter Spurious Emission-Conducted	15.247	/	P
Transmitter Spurious Emission-Radiated	15.247,15.209,	/	P
AC Powerline Conducted Emission	15.107,15.207	/	P

Please refer to part 5 for detail.

The measurements are according to ANSI C63.10.

Terms used in Verdict column

P	Pass, the EUT complies with the essential requirements in the standard.
NP	Not Perform, the test was not performed by ECIT.
NA	Not Applicable, the test was not applicable.
F	Fail, the EUT does not comply with the essential requirements in the standard.

Test Conditions

Tnom	Normal Temperature
Tmin	Low Temperature
Tmax	High Temperature
Vnom	Normal Voltage
Vmin	Low Voltage

Vmax	High Voltage
Hnom	Norm Humidity
Anom	Norm Air Pressure

For this report, all the test case listed above are tested under Normal Temperature and Normal Voltage, and also under norm humidity, the specific conditions as following:

Temperature	Tnom	25℃
Voltage	Vnom	12V
Humidity	Hnom	48%
Air Pressure	Anom	1010hPa

Note:

a. All the test data for each data were verified, but only the worst case was reported.

b.The GFSK, π/4 DQPSK and 8DPSK were set in DH1 for GFSK, 2-DH1 for π/4 DQPSK, 3-DH1 for 8DPSK.

c.The DC and low frequency voltages' measurement uncertainty is ±2%.

5.1. Notes

All reported tests were carried out on a sample equipment to demonstrate limited compliance with section 3.

The test results of this test report relate exclusively to the item(s) tested as specified in section 5.

5.2. Statements

The F4600, supporting BT/BLE/ WLAN, manufactured by Shanghai Sunmi Technology Co.,Ltd., Ltd., which is a new product for testing.

ECIT has verified that the compliance of the tested device specified in section 5 of this test report is successfully evaluated according to the procedure and test methods as defined in type certification requirement listed in section 5 of this test report.

6. Test result

6.1. Peak Output Power-Conducted

6.1.1 Measurement Limit

Standard	Limit (dBm)
FCC Part 15.247(b)(1)	< 30

6.1.2 Test Condition:

Hopping Mode	RBW	VBW	Span	Sweeptime
Hopping OFF	3MHz	10MHz	9MHz	Auto

6.1.3 Test procedure

The measurement is according to ANSI C63.10 clause 7.8.5.

1. The output power of EUT was connected to the spectrum analyzer and CBT32 by cable and divide. The path loss was compensated to the results for each measurement.
2. Enable EUT transmitter maximum power continuously.
3. Measure the conducted output power and record the results it.

6.1.4 Measurement Uncertainty:

Measurement Uncertainty	±0.88dB

6.1.5 Measurement Results:

For GFSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	1.43	2.12	2.27	P
	Fig.1	Fig.2	Fig.3	

For π/4 DQPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	1.45	2.11	2.25	P
	Fig.4	Fig.5	Fig.6	

For 8DPSK

Channel	Ch0 2402 MHz	Ch39 2441 MHz	CH78 2480 MHz	Conclusion
Peak Conducted Output Power (dBm)	1.78	2.54	2.79	P
	Fig.7	Fig.8	Fig.9	

Conclusion: PASS

Test graphs an below

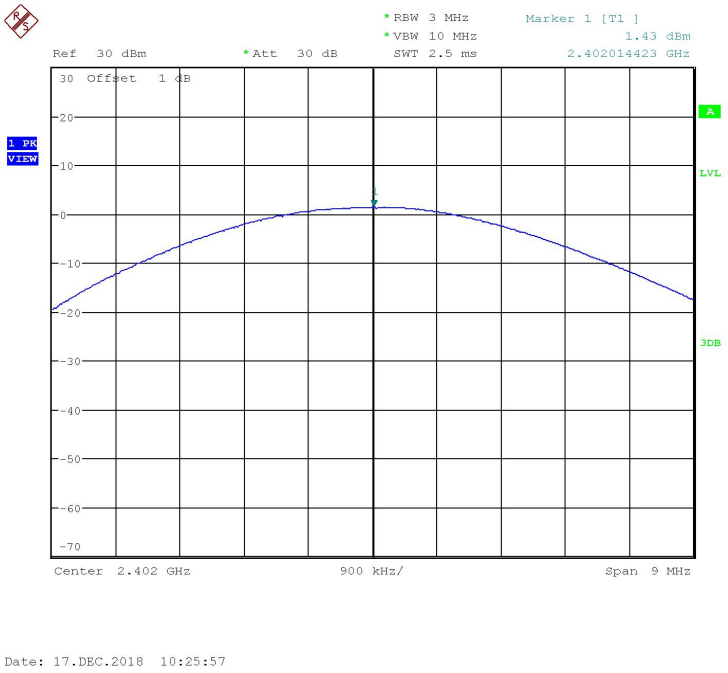


Fig.1 Peak Conducted Output Power CH0, DH1

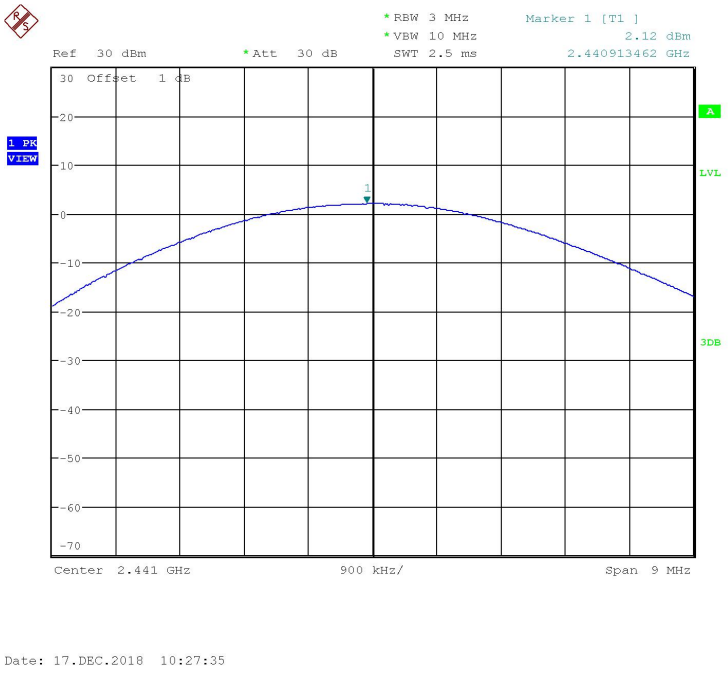


Fig.2 Peak Conducted Output Power CH39, DH1

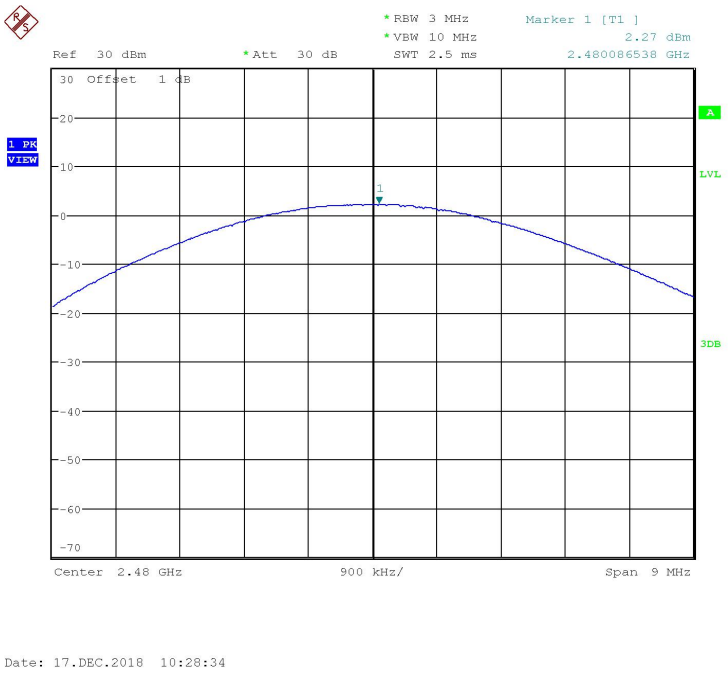


Fig.3 Peak Conducted Output Power CH78, DH1

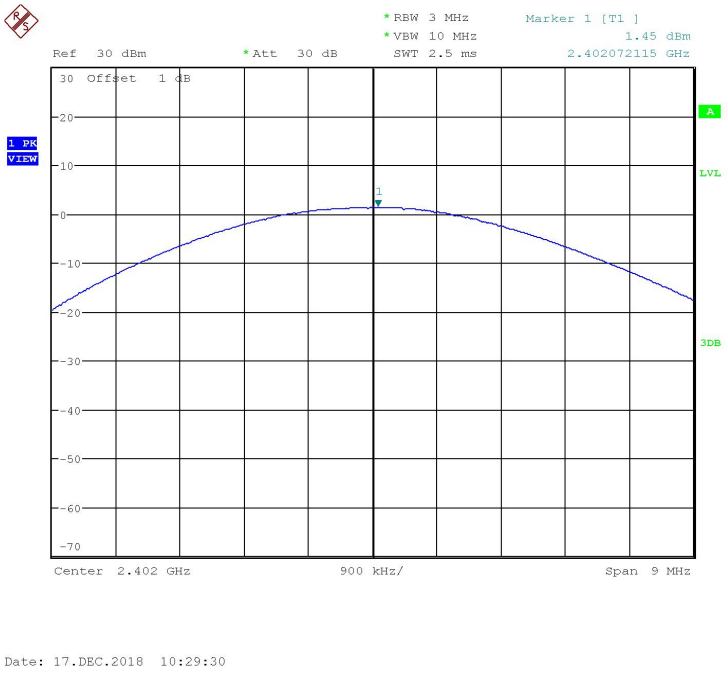


Fig.4 Peak Conducted Output Power CH0, 2DH1

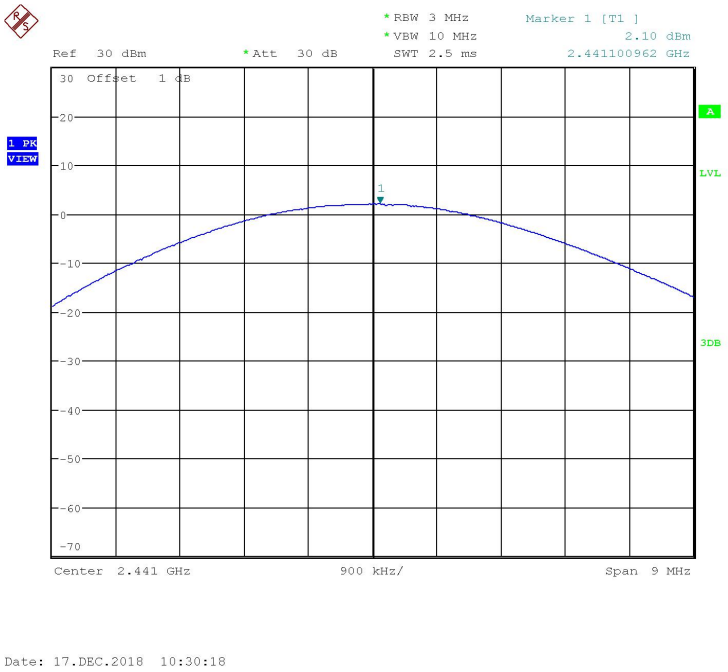


Fig.5 Peak Conducted Output Power CH39, 2DH1

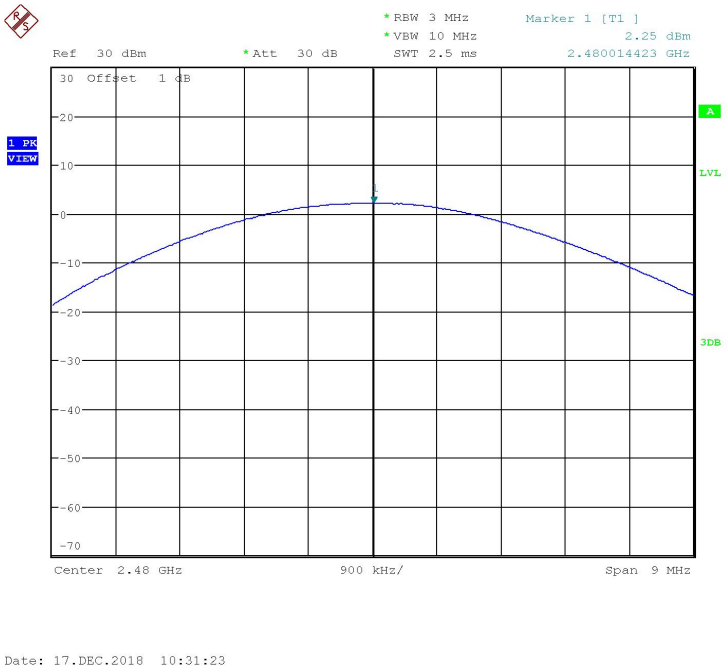


Fig.6 Peak Conducted Output Power CH78, 2DH1

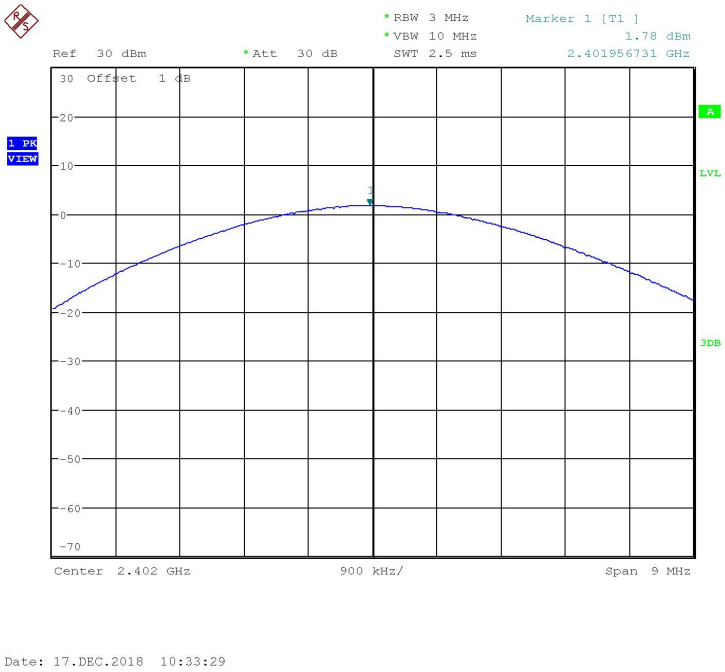


Fig.7 Peak Conducted Output Power CH0, 3DH1

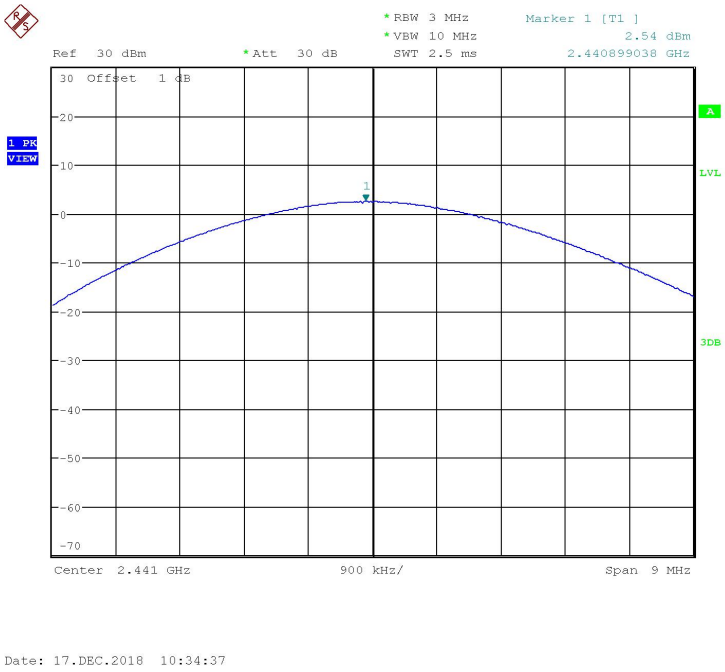


Fig.8 Peak Conducted Output Power CH39, 3DH1

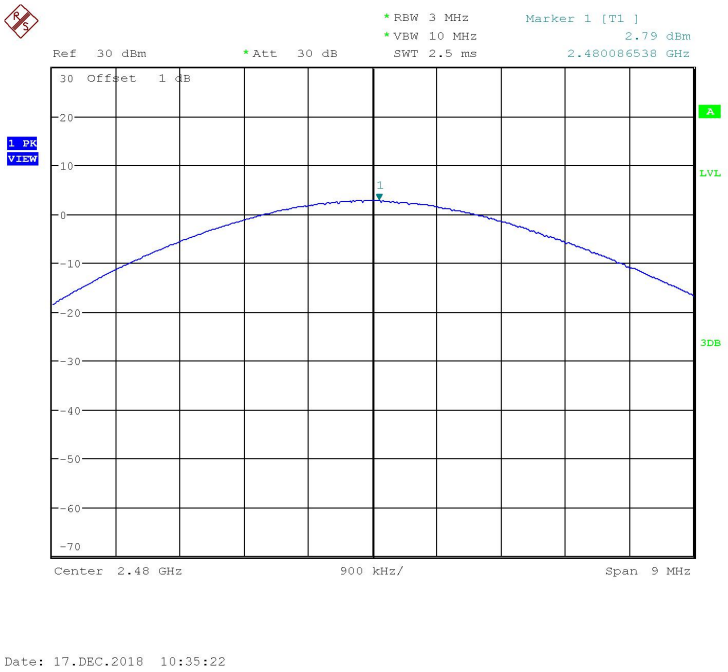


Fig.9 Peak Conducted Output Power CH78, 3DH1

6.2. Frequency Band Edges-Conducted

6.2.1 Measurement Limit:

Standard	Limited(dBc)
FCC 47 CFR Part 15.247(d)	>20

6.2.2 Test procedure

The measurement is according to ANSI C63.10 clause 7.8.6.

1. Connect the EUT to spectrum analyzer.
2. Set RBW=100KHz, VBW=300KHz, span more than 1.5 times channel bandwidth (2MHz).
3. Detector =peak, sweep time=auto couple, trace mode=max hold.
4. Allow sweep to continue until the trace stabilizes.

6.2.3 Measurement Uncertainty:

Measurement Uncertainty	±4.56dB

6.2.4 Measurement results

For GFSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion

0	Hopping OFF	Fig.10	P
	Hopping ON	Fig.11	P
78	Hopping OFF	Fig.12	P
	Hopping ON	Fig.13	P

For π/4 DQPSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.14	P
	Hopping ON	Fig.15	P
78	Hopping OFF	Fig.16	P
	Hopping ON	Fig.17	P

For 8DPSK

Channel	Hopping	Band Edge Power (dBc)	Conclusion
0	Hopping OFF	Fig.18	P
	Hopping ON	Fig.19	P
78	Hopping OFF	Fig.20	P
	Hopping ON	Fig.21	P

Conclusion: PASS

Test graphs an below

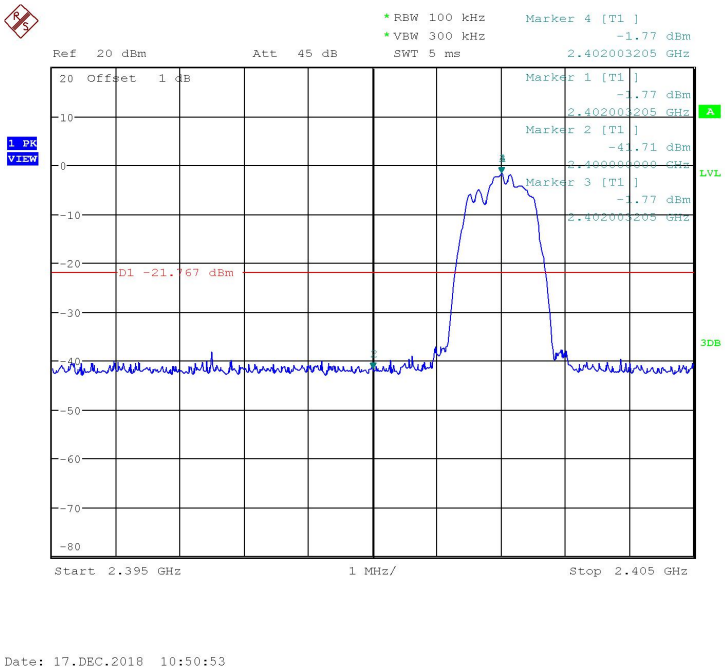


Fig.10 Frequency Band Edge: GFSK, Ch0, Hopping OFF

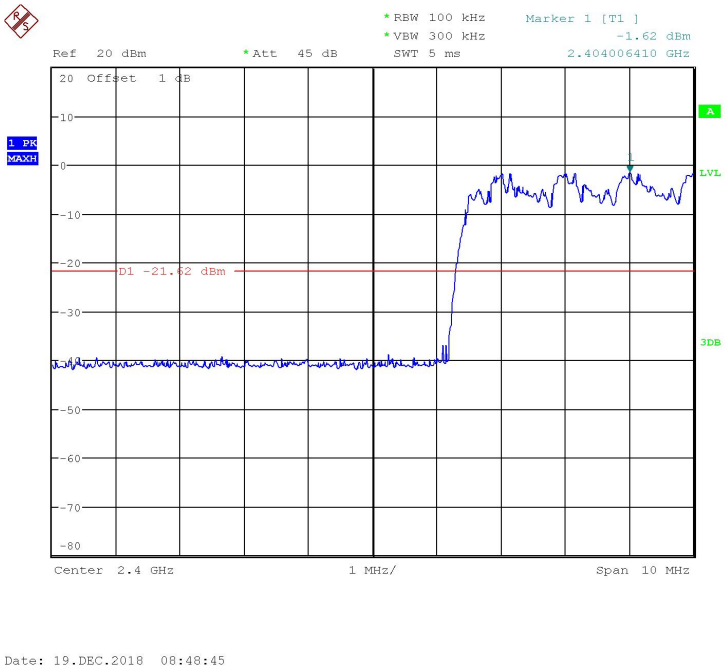
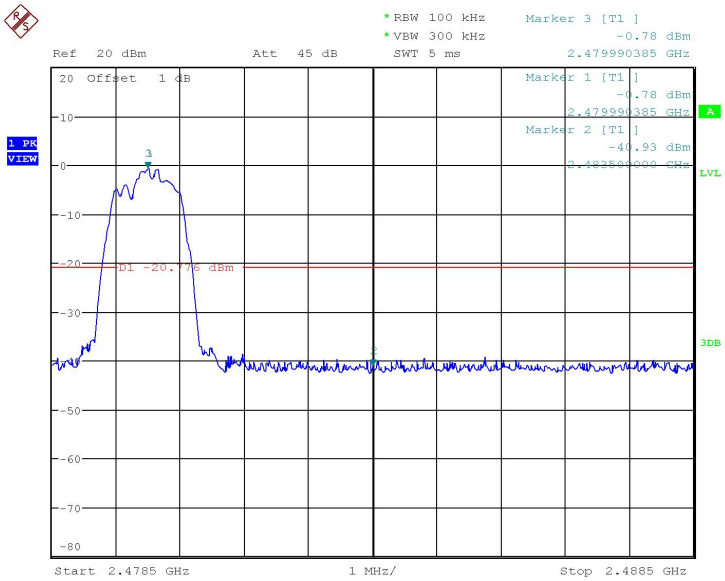
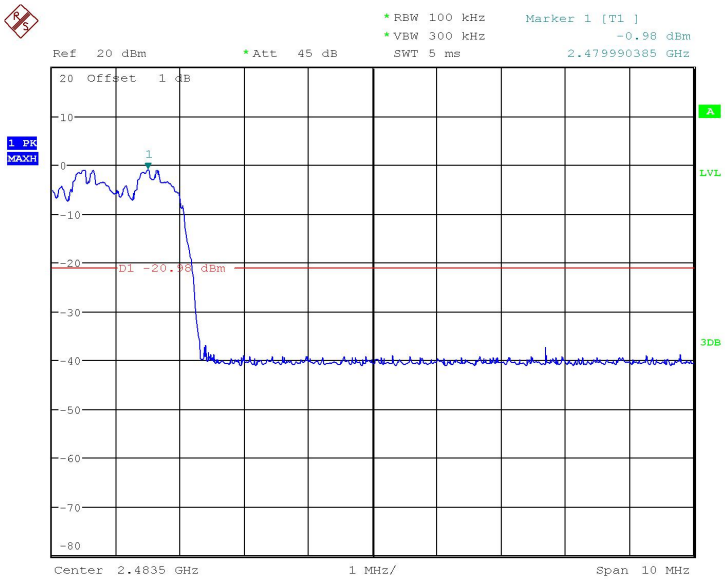


Fig.11 Frequency Band Edge: GFSK, Ch0, Hopping ON



Date: 17.DEC.2018 10:55:41

Fig.12 Frequency Band Edge: GFSK, Ch78, Hopping OFF



Date: 19.DEC.2018 08:55:35

Fig.13 Frequency Band Edge: GFSK, Ch78, Hopping ON

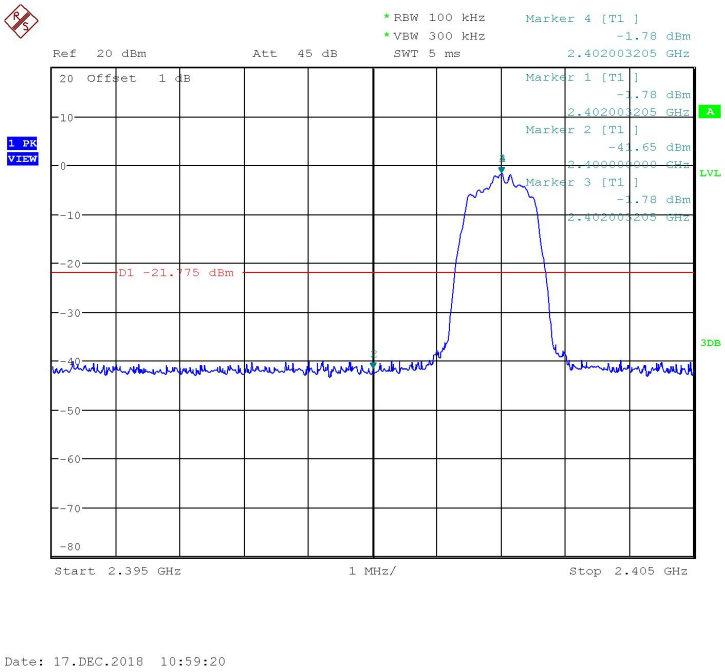


Fig.14 Frequency Band Edge: π/4 DQPSK, Ch0, Hopping OFF

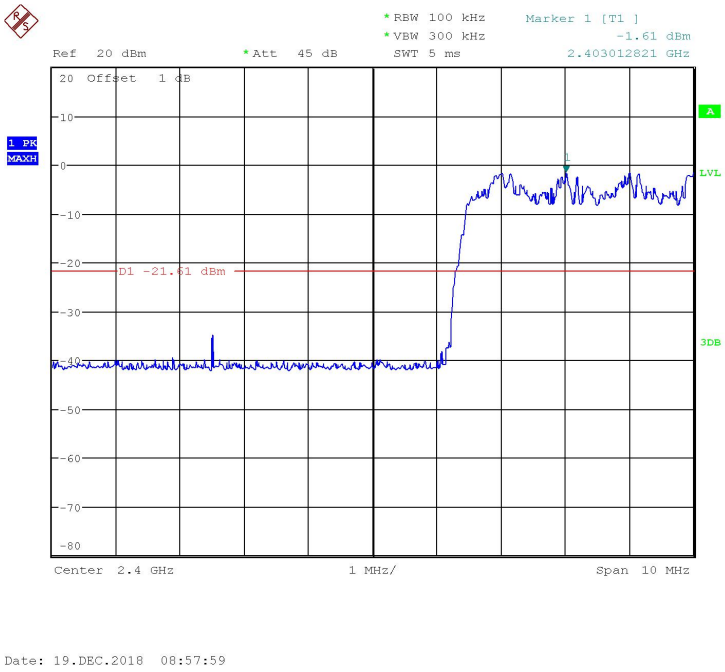


Fig.15 Frequency Band Edge: π/4 DQPSK, Ch0, Hopping ON

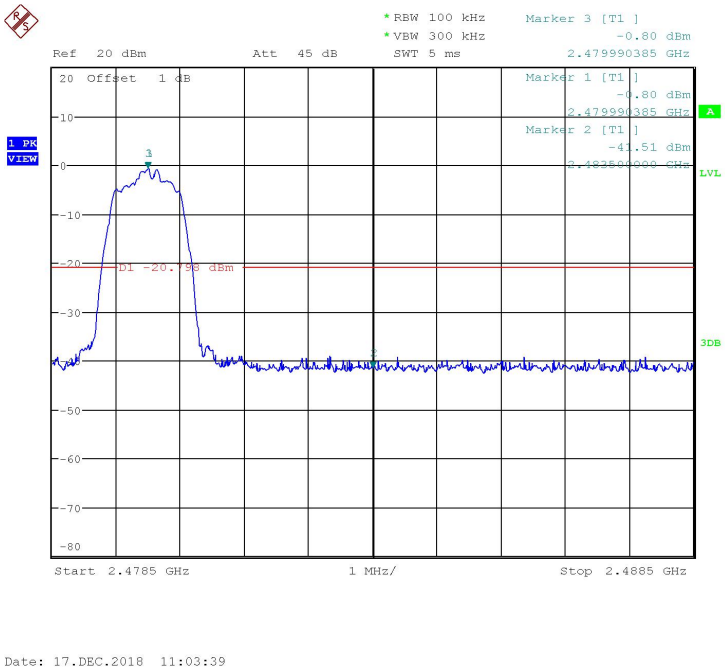


Fig.16 Frequency Band Edge: π/4 DQPSK, Ch78, Hopping OFF

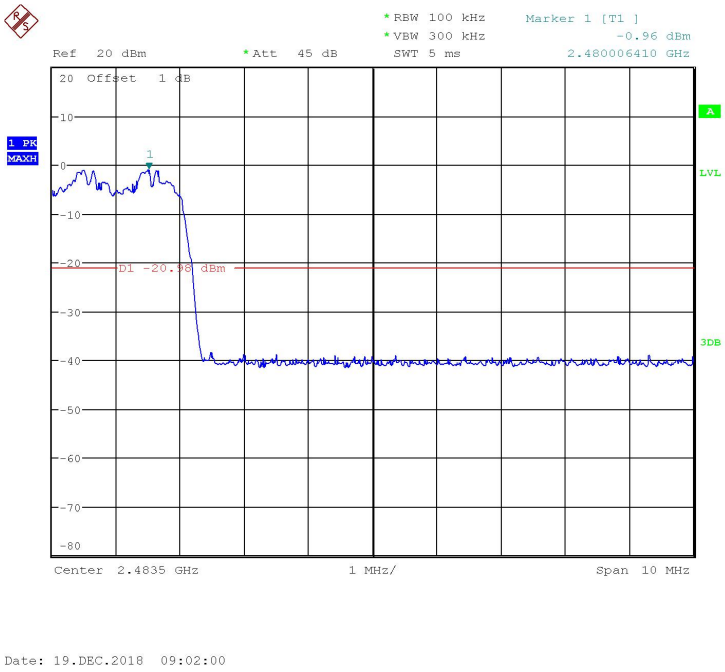
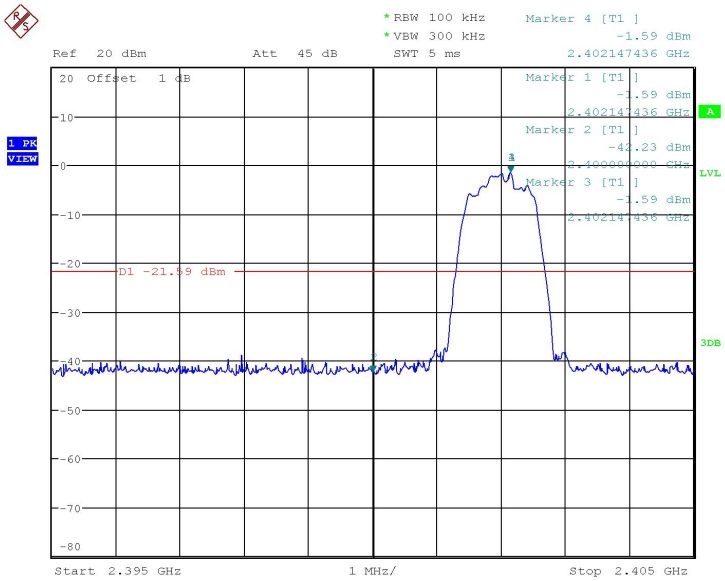
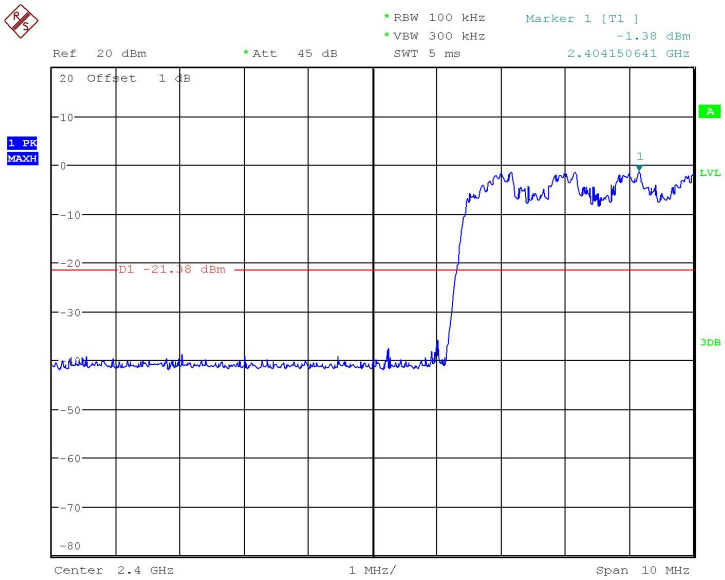


Fig.17 Frequency Band Edge: π/4 DQPSK, Ch78, Hopping ON



Date: 17.DEC.2018 11:06:07

Fig.18 Frequency Band Edge: 8DPSK, Ch0, Hopping OFF



Date: 19.DEC.2018 09:05:56

Fig.19 Frequency Band Edge: 8DPSK, Ch0, Hopping ON

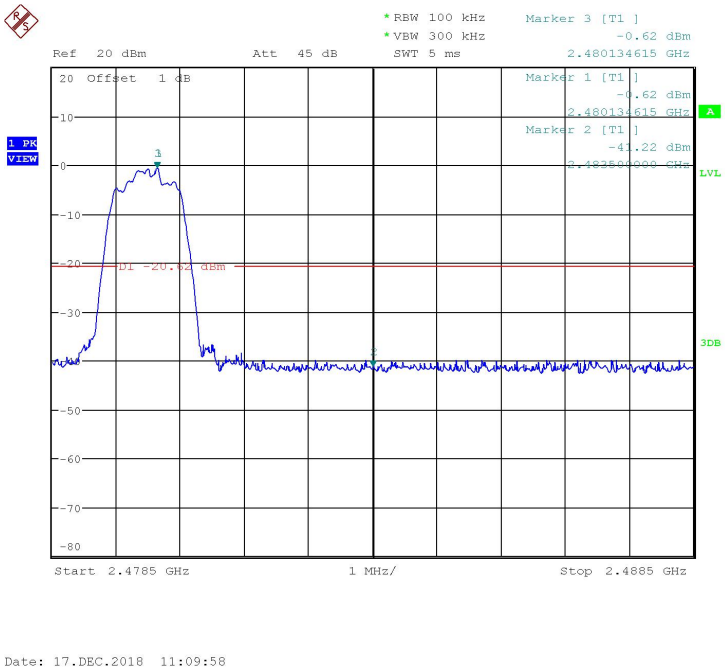


Fig.20 Frequency Band Edge: 8DPSK, Ch78, Hopping OFF

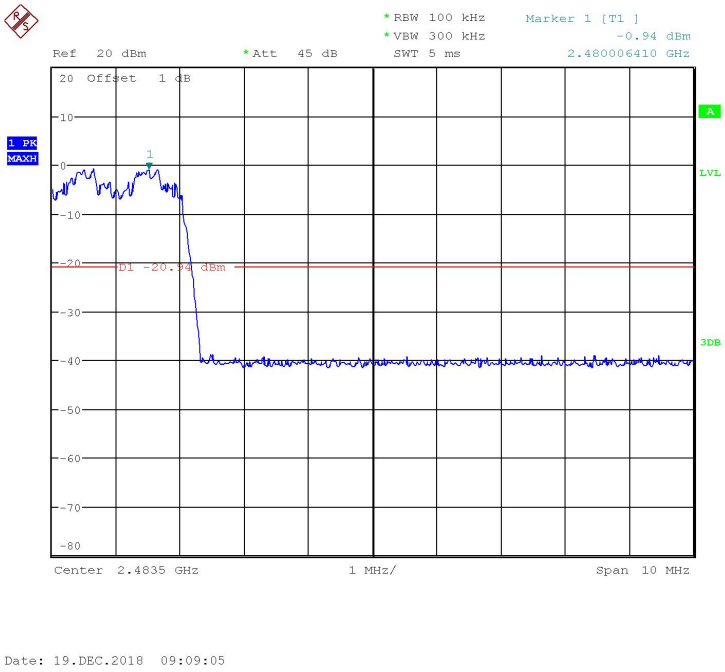


Fig.21 Frequency Band Edge: 8DPSK, Ch78, Hopping ON

6.3. Conducted Emission

6.3.1 Measurement Limit:

Standard	Limit
FCC 47 CFR Part15.247 (d)	20dB below peak output power in 100KHz bandwidth

6.3.2 Test procedures

The measurement is according to ANSI C63.10 clause 7.8.8.

1. Connect the EUT to spectrum analyzer.
2. Set RBW=100KHz, VBW=300KHz.
3. Detector =peak, sweep time=auto couple, trace mode=max hold.

6.3.3 Measurement Uncertainty:

Measurement Uncertainty	±4.56dB

6.3.4 Measurement Results:

For GFSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.22	P
	30MHz~26GHz	Fig.23	P
Ch39 2441MHz	Center Freq.	Fig.24	P
	30MHz~26GHz	Fig.25	P
Ch78 2480MHz	Center Freq.	Fig.26	P
	30MHz~26GHz	Fig.27	P

For π/4 DQPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.28	P
	30MHz~26GHz	Fig.29	P
Ch39 2441MHz	Center Freq.	Fig.30	P
	30MHz~26GHz	Fig.31	P
Ch78 2480MHz	Center Freq.	Fig.32	P
	30MHz~26GHz	Fig.33	P

For 8DPSK

Channel	Frequency Range	Test Results	Conclusion
Ch0 2402MHz	Center Freq.	Fig.34	P
	30MHz~26GHz	Fig.35	P

Ch39 2441MHz	Center Freq.	Fig.36	P
	30MHz~26GHz	Fig.37	P
Ch78 2480MHz	Center Freq.	Fig.38	P
	30MHz~26GHz	Fig.39	P

Conclusion: PASS

Test graphs as below

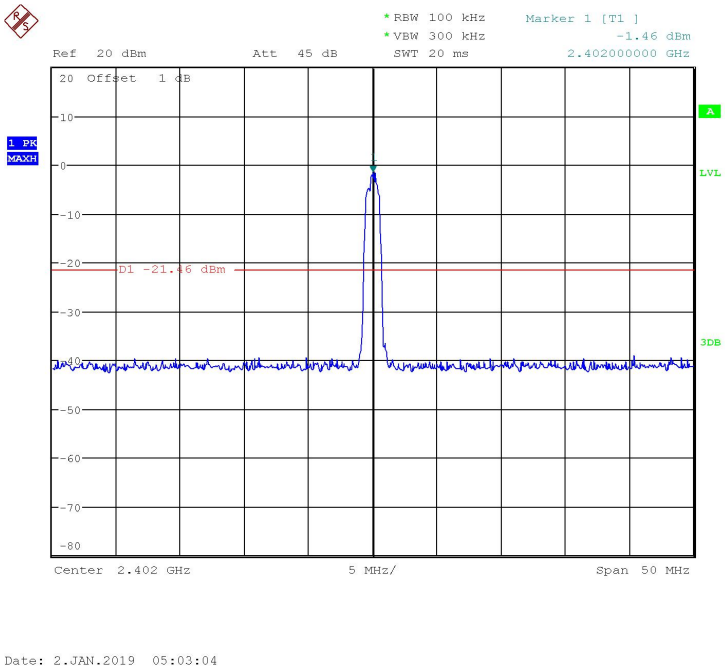


Fig.22 Conducted spurious emission: GFSK, Ch0, 2402MHz

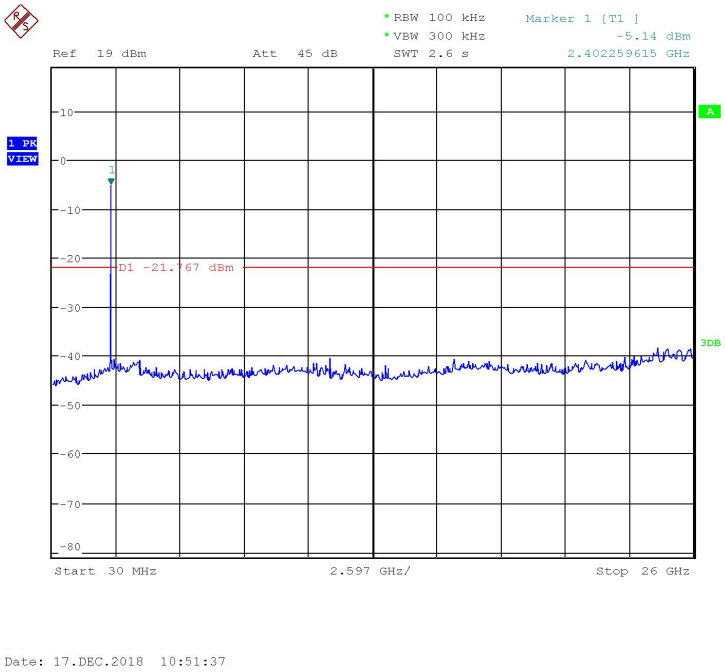


Fig.23 Conducted spurious emission: GFSK, Ch0, 30MHz~26GHz

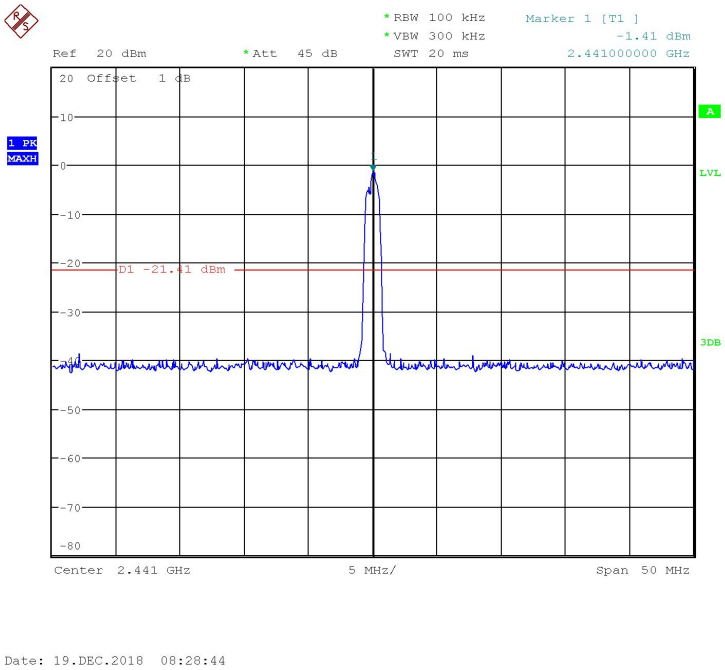


Fig.24 Conducted spurious emission: GFSK, Ch39, 2441MHz

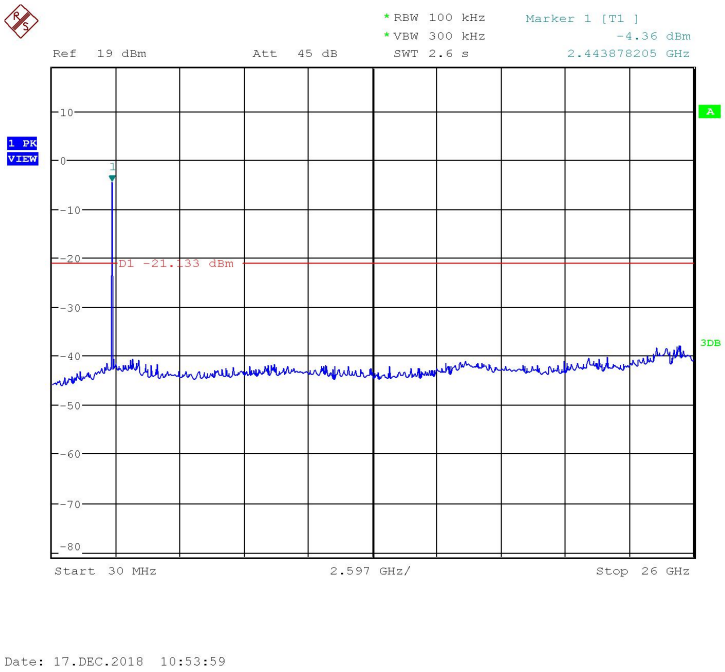


Fig.25 Conducted spurious emission: GFSK, Ch39, 30MHz~26GHz

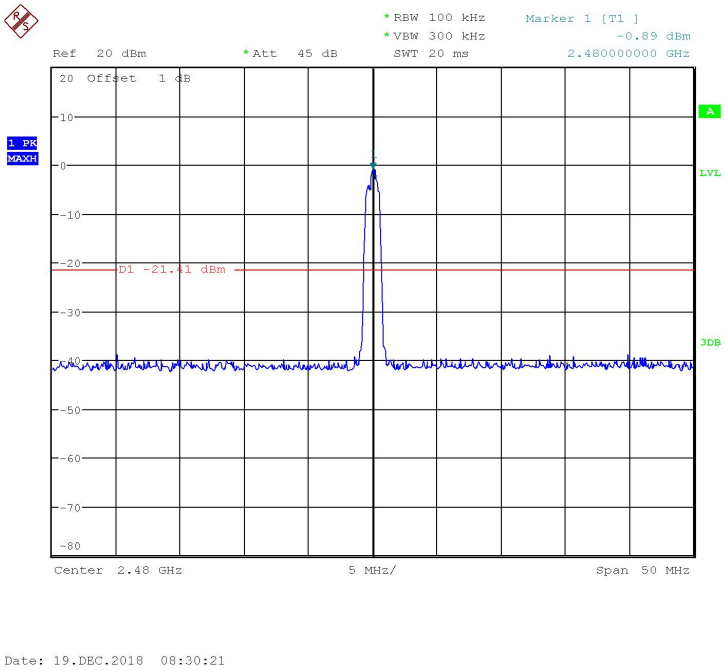


Fig.26 Conducted spurious emission: GFSK, Ch78, 2480MHz

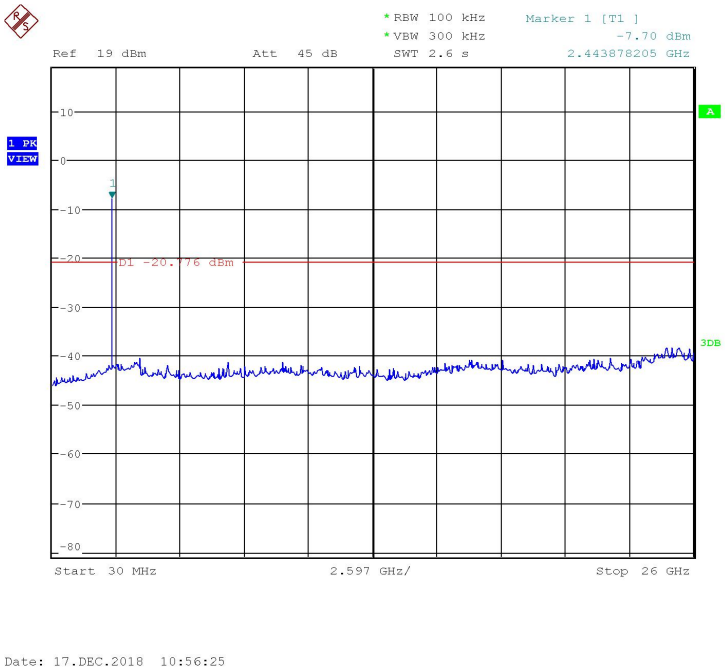


Fig.27 Conducted spurious emission: GFSK, Ch78, 30MHz~26GHz

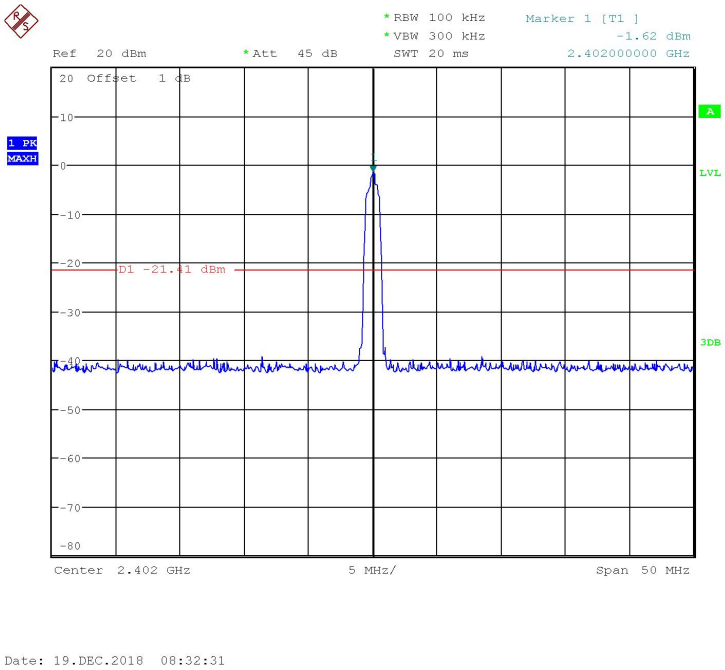


Fig.28 Conducted spurious emission: π/4 DQPSK, Ch0, 2402MHz

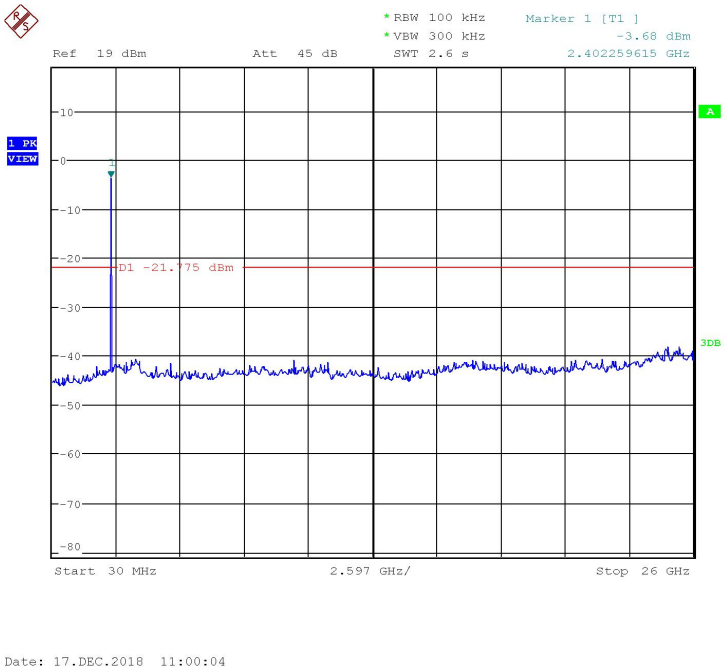


Fig.29 Conducted spurious emission: π/4 DQPSK, Ch0, 30MHz~26GHz

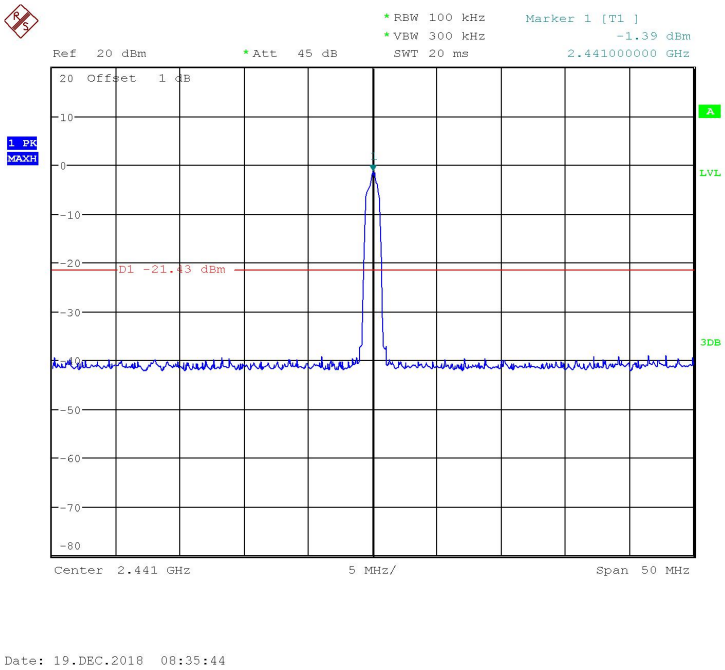


Fig.30 Conducted spurious emission: π/4 DQPSK, Ch39, 2441MHz

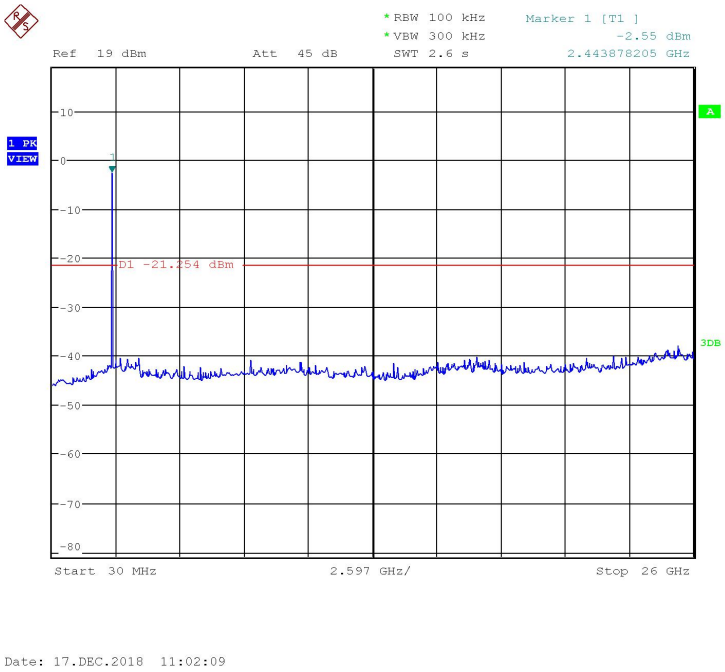


Fig.31 Conducted spurious emission: π/4 DQPSK, Ch39, 30MHz~26GHz

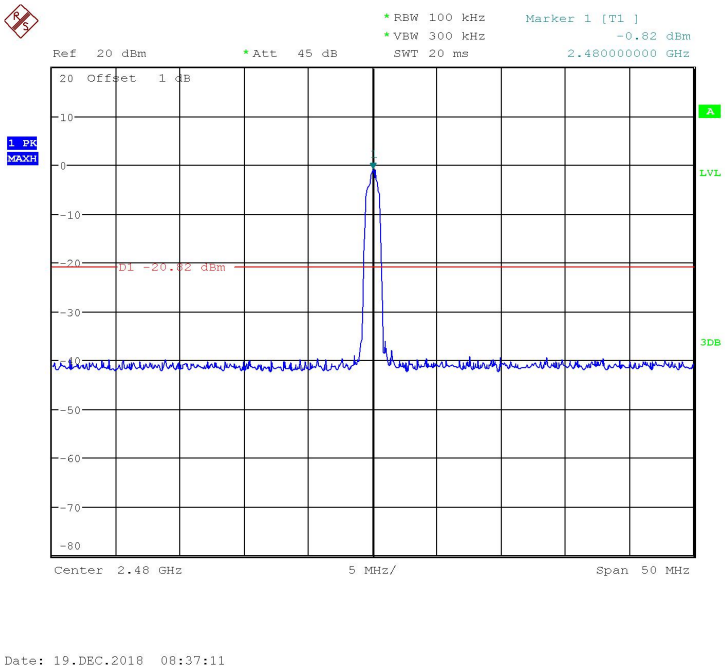


Fig.32 Conducted spurious emission: π/4 DQPSK, Ch78, 2480MHz

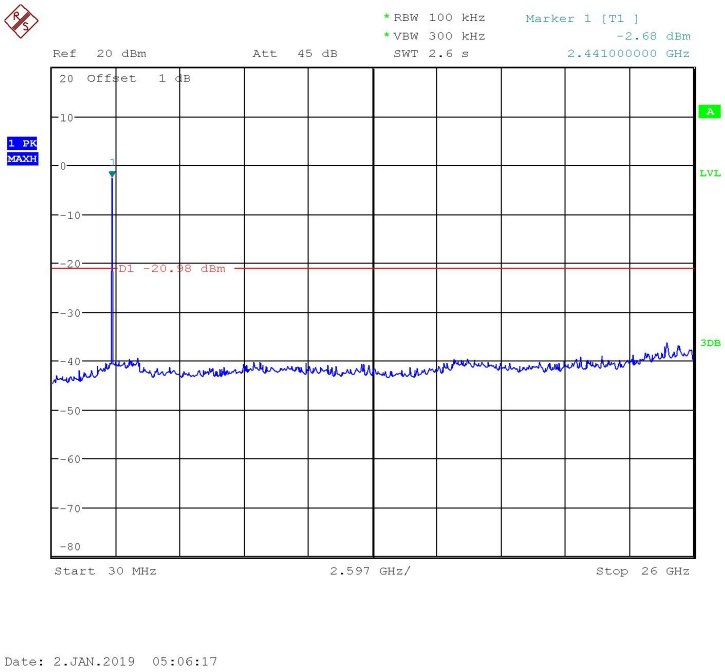


Fig.33 Conducted spurious emission: π/4 DQPSK, Ch78, 30MHz~26GHz

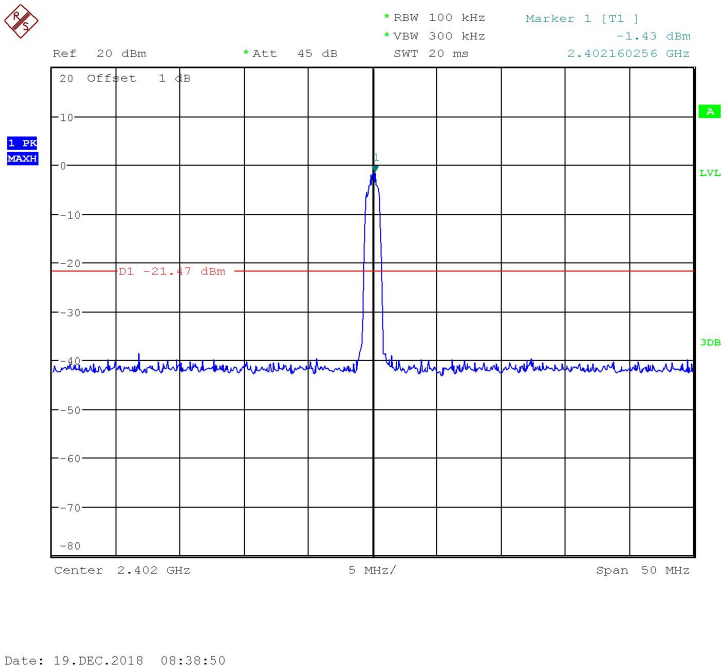


Fig.34 Conducted spurious emission: 8DPSK, Ch0, 2402MHz